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INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)			<i>APQ Rec'd DCTM TO 02 JUN 2006</i>		
			APPLICANTS Satoshi AOYAMA et al.		
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U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name	
/AM/	1	2002/0028367 A1	03/07/2002	Sammes et al.	
	2	5,753,385	05/19/1998	Jankowski et al.	
	3	6,645,656 B1	11/11/2003	Chen et al.	
	4	5,741,406	04/21/1998	Barnett et al.	
	5	4,963,239	10/16/1990	Shimamura et al.	
	6	6,197,167 B1	03/06/2001	Tanaka	
	7	5,656,387	08/12/1997	Barnett et al.	
	8	6,428,920 B1	08/06/2002	Badding et al.	
	9	5,543,239	08/06/1996	Virkar et al.	
	10	6,387,230 B1	05/14/2002	Murphy et al.	
	11	2003/0059658 A1	03/27/2003	Kohler et al.	
	12	6,066,364	05/23/2000	Blass et al.	
	13	5,415,888	05/16/1995	Banaerjee et al.	
	14	2002/0055034 A1	05/09/2002	Fukuda et al.	
	15	6,475,249 B1	11/05/2002	Hsu et al.	
	16	2003/0091890 A1	05/15/2003	Fukuda et al.	
	17	6,004,696	12/21/1999	Barnett et al.	
↓	18	5,434,024	07/18/1995	Ikeda et al.	
	19	2004/0214055 A1	10/28/2004	Aoyama et al.	
/AM/	20	2004/0043277 A1	04/03/2004	Ito et al.	

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
/AM/	21	JP A 5-299105	11/12/1993	Japan	X	X
	22	EP 0 621 648 A2	10/26/1994	Europe		
↓	23	JP A 4-167710	06/15/1992	Japan	X	
/AM/	24	EP 1 258 283 A1	11/20/2002	Europe		

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)		
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